

**Notice of References Cited**

Application/Control No.

10/594,760

Applicant(s)/Patent Under  
Reexamination  
INOOKA ET AL.

Examiner

Gregg Polansky

Art Unit

1614

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,066,374	05-2000	Healy et al.	428/35.7
	B	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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